

April 2015

FGH40T65SHD 650 V, 40 A Field Stop Trench IGBT

Features

- Maximum Junction Temperature: T_J =175°C
- · Positive Temperature Co-efficient for Easy Parallel Operating
- · High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.6 \text{ V(Typ.)} @ I_C = 40 \text{ A}$
- 100% of the Parts Tested for I_{LM}(1)
- · High Input Impedance
- Fast Switching
- · Tighten Parameter Distribution
- · RoHS Compliant

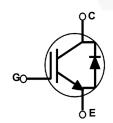
General Description

Using novel field stop IGBT technology, Fairchild's new series of field stop 3rd generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Applications

· Solar Inverter, UPS, Welder, Telecom, ESS, PFC





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		FGH40T65SHD_F155	Unit
V _{CES}	Collector to Emitter Voltage		650	V
V _{GES}	Gate to Emitter Voltage		± 20	V
*GES	Transient Gate to Emitter Voltage		± 30	V
Ic	Collector Current	@ T _C = 25°C	80	Α
	Collector Current	@ T _C = 100°C	40	Α
I _{LM (1)}	Pulsed Collector Current	@ T _C = 25°C	120	Α
I _{CM (2)}	Pulsed Collector Current		120	Α
I _F	Diode Forward Current	@ T _C = 25°C	40	Α
'-	Diode Forward Current	@ T _C = 100°C	20	Α
I _{FM (2)}	Pulsed Diode Maximum Forward Curren	t	120	Α
P _D	Maximum Power Dissipation	@ T _C = 25°C	268	W
. 0	Maximum Power Dissipation	@ T _C = 100°C	134	W
TJ	Operating Junction Temperature		-55 to +175	°C
T _{stg}	Storage Temperature Range		-55 to +175	°C
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Notes:

- 1. $\rm V_{CC}$ = 400 V, $\rm V_{GE}$ = 15 V, $\rm I_{C}$ =120 A, $\rm R_{G}$ = 30 $\Omega,$ Inductive Load
- 2. Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	FGH40T65SHD_F155	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case, Max.	0.56	°C/W
$R_{\theta JC}(Diode)$	Thermal Resistance, Junction to Case, Max.	1.71	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

Package Marking and Ordering Information

Part Number Top Mark		Package	Package Packing Method		Tape Width	Quantity
FGH40T65SHD_F155	FGH40T65SHD	TO-247 G03	Tube	-	-	30

Electrical Characteristics of the IGBT T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	eteristics					
BV _{CES}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V$, $I_C = 1$ mA	650	-	-	V
ΔBV _{CES} / ΔΤ _J	Temperature Coefficient of Breakdown Voltage	I _C = 1 mA, Reference to 25°C	-	0.6	-	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	250	μΑ
I _{GES}	G-E Leakage Current	V _{GE} = V _{GES} , V _{CE} = 0 V	-	-	±400	nA
On Charac	teristics					
V _{GE(th)}	G-E Threshold Voltage	I _C = 40 mA, V _{CE} = V _{GE}	4.0	5.5	7.5	V
()		I _C = 40 A, V _{GE} = 15 V	-	1.6	2.1	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 40 A, V _{GE} = 15 V, T _C = 175°C	-	2.14	-	V
Dynamic C	Characteristics					
C _{ies}	Input Capacitance		-	1995	-	pF
C _{oes}	Output Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$ f = 1 MHz	-	70	-	pF
C _{res}	Reverse Transfer Capacitance	- 1 - 11VII 12	-	23	-	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time		_	19.2	-	ns
t _r	Rise Time		-	34.4	-	ns
t _{d(off)}	Turn-Off Delay Time	V _{CC} = 400 V, I _C = 40 A,	-	65.6	-	ns
t _f	Fall Time	$R_G = 6 \Omega, V_{GE} = 15 V,$	-	9.6	-	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C	-	1010	- //	uJ
E _{off}	Turn-Off Switching Loss		-	297	-	uJ
E _{ts}	Total Switching Loss		-	1307	- \	uJ
t _{d(on)}	Turn-On Delay Time		-	18.4	-	ns
t _r	Rise Time		-	32.8	-	ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 400 \text{ V}, I_{C} = 40 \text{ A},$ $R_{G} = 6 \Omega, V_{GE} = 15 \text{ V},$	-	71.2	-	ns
t _f	Fall Time		-	14.4	-	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 175°C	-	1390	-	uJ
E _{off}	Turn-Off Switching Loss		-	541	-	uJ
E _{ts}	Total Switching Loss		-	1931	-	uJ

Electrical Characteristics of the IGBT (Continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Unit
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 40 A, V _{GE} = 15 V	-	72.2	-	nC
Q _{ge}	Gate to Emitter Charge		-	13.5	-	nC
Q _{gc}	Gate to Collector Charge		-	28.5	-	nC

Electrical Characteristics of the Diode T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max	Unit
V _{FM}	Diode Forward Voltage	I _F = 20 A	T _C = 25°C	-	2.2	2.8	V
FINI			$T_{\rm C} = 175^{\rm o}{\rm C}$	-	1.94	-	
E _{rec}	Reverse Recovery Energy		T _C = 175°C	-	50	-	uJ
t _{rr}	Diode Reverse Recovery Time	$I_F = 20 \text{ A}, dI_F/dt = 200 \text{ A}/\mu\text{s}$	$T_{\rm C} = 25^{\rm o}{\rm C}$	/ -	31.8	-	ns
orr			T _C = 175°C	-	192	-	
Q _{rr}	Diode Reverse Recovery Charge		$T_{\rm C} = 25^{\rm o}{\rm C}$	\ -	50.6	-	nC
√ II			T _C = 175°C	-	699	-	

Figure 1. Typical Output Characteristics

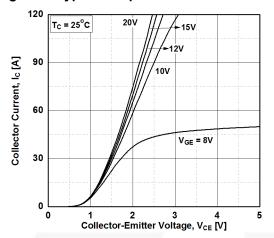


Figure 3. Typical Saturation Voltage Characteristics

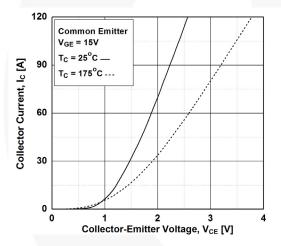


Figure 5. Saturation Voltage vs. V_{GE}

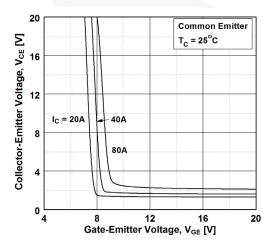


Figure 2. Typical Output Characteristics

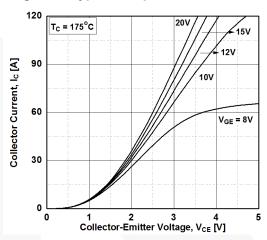


Figure 4. Saturation Voltage vs. Case
Temperature at Variant Current Level

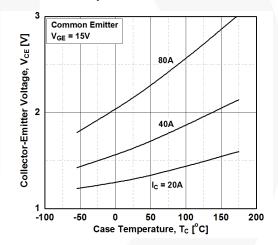


Figure 6. Saturation Voltage vs. V_{GE}

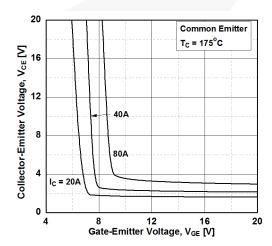
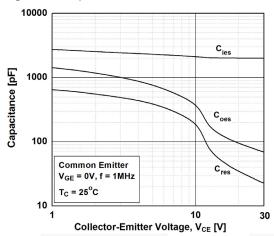


Figure 7. Capacitance Characteristics



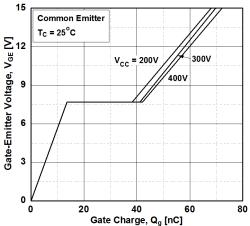


Figure 8. Gate charge Characteristics

Figure 9. Turn-on Characteristics vs. **Gate Resistance**

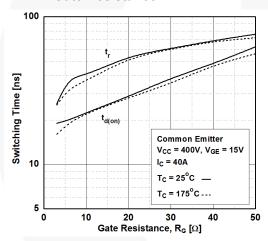


Figure 10. Turn-off Characteristics vs. **Gate Resistance**

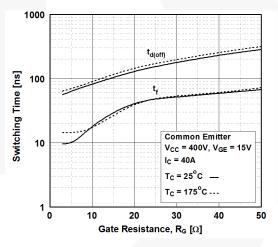


Figure 11. Switching Loss vs. **Gate Resistance**

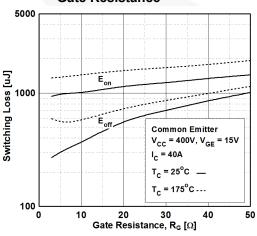


Figure 12. Turn-on Characteristics vs. **Collector Current**

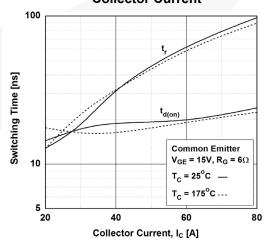


Figure 13. Turn-off Characteristics vs. Collector Current

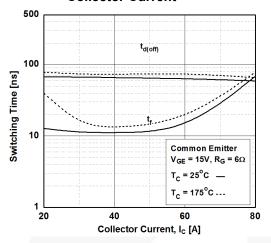


Figure 14. Switching Loss vs. Collector Current

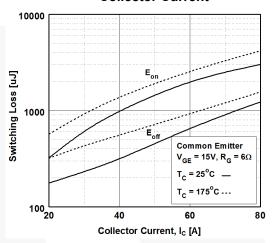


Figure 15. Load Current Vs. Frequency

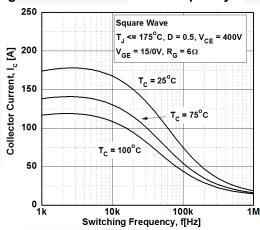


Figure 16. SOA Characteristics

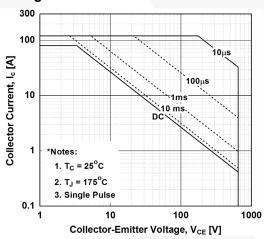


Figure 17. Forward Characteristics

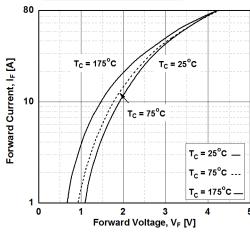


Figure 18. Reverse Recovery Current

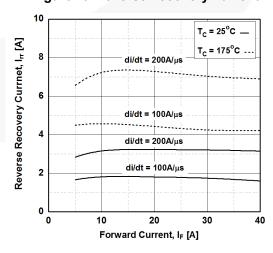


Figure 19. Reverse Recovery Time

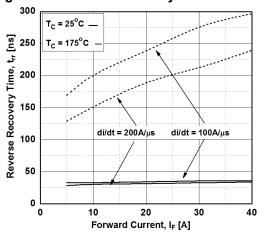


Figure 20. Stored Charge

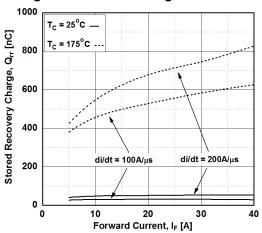


Figure 21.Transient Thermal Impedance of IGBT

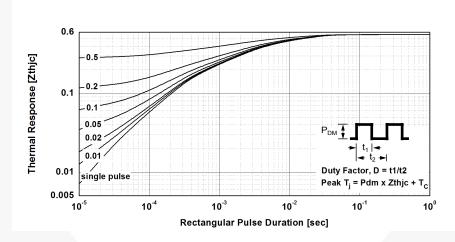
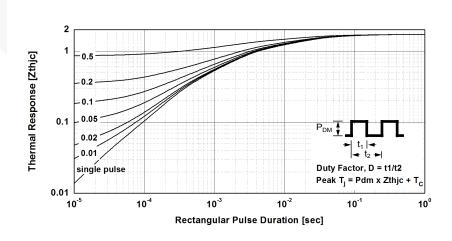


Figure 22. Transient Thermal Impedance of Diode



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